Search Notes



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Examiner

CECILIA M JAISLE

SEARCHED				
Class	Subclass		Date	Examiner
514	264.11		1/15/2008	C. Jaisle
544	270		1/15/2008	C. Jaisle

SEARCH NOTES

Search Notes	Date	Examiner	
STN &^ Inventor Names searched by STIC	1/15/2008	C. Jaisle	

INTERFERENCE SEARCH

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